

Search Notes

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Christopher P. Schwartz

Applicant(s)/Patent under
Reexamination

LEE, JONG-CHAN

Art Unit

3683

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
188	all above	9/8/2005	CPS
219	202	9/8/2005	

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
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